

## CHIPLINK N-Channel Enhancement Mode Power MOSFET

### Description

The LX3404S combines advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. This device is suitable for use as a load switch or PWM applications.

### Features

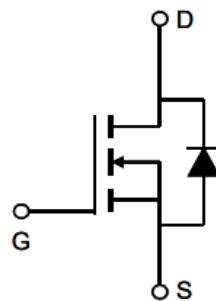
- $V_{DS}=30V$ ,  $I_D=5.8A$
- $R_{DS(ON)}\text{typ.}=19m\Omega$  @  $V_{GS}=10V$
- $R_{DS(ON)}\text{typ.}=26m\Omega$  @  $V_{GS}=4.5V$

- Low gate charge
- High power and current handing capability
- Termination is Lead-free and RoHS Compliant

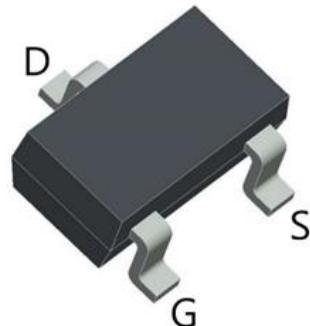


### Applications

- PWM applications
- Load switch
- Power Management



Schematic Diagram



SOT23 Package

### Maximum Ratings ( $T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D$	5.8	A
Pulsed Drain Current <sup>B</sup>	$I_{DM}$	23	A
Maximum Power Dissipation <sup>A</sup>	$P_D$	1.3	W
Junction and Storage Temperature Range	$T_J$ , $T_{STG}$	-55 To 150	°C

### Thermal Characteristic

Thermal Resistance, Junction to Ambient	$R_{QJA}$	89	°C/W
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**Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise specified)**

Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	30			V
Gate-Threshold Voltage	V <sub>th(GS)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250 uA	1.2	1.6	2.2	V
Gate-body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V			±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	uA
Drain-Source On-Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =5A		19	25	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =4A		26	35	mΩ
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =5V, I <sub>D</sub> =5A	10			s
<b>Dynamic Characteristics</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 15V, V <sub>GS</sub> =0V, F=1MHz		635		pF
Output Capacitance	C <sub>oss</sub>			56		
Reverse Transfer Capacitance	C <sub>rss</sub>			46		
<b>Switching Capacitance</b>						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 15V, R <sub>L</sub> =2.7Ω V <sub>GS</sub> = 10V, R <sub>GEN</sub> =3Ω		3.3		nS
Turn-on Rise Time	t <sub>r</sub>			4.8		nS
Turn-off Delay Time	t <sub>d(off)</sub>			26		nS
Turn-off Fall Time	t <sub>f</sub>			4		nS
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = 15V, I <sub>D</sub> =5A, V <sub>GS</sub> =4.5V		5.2		nC
Gate-Source Charge	Q <sub>gs</sub>			1.2		nC
Gate-Drain Charge	Q <sub>gd</sub>			1.7		nC
<b>Drain-Source Diode Characteristics</b>						
Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =5A			1.2	V
Diode Forward Current	I <sub>s</sub>				5.8	A

**Notes:**

- The Power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using≤10s junction-to ambient thermal resistance.
- Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C.Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.
- The Static characteristics in Figures are obtained using <300 μ s pulses, duty cycle 2% max.

## Typical Electrical and Thermal Characteristics

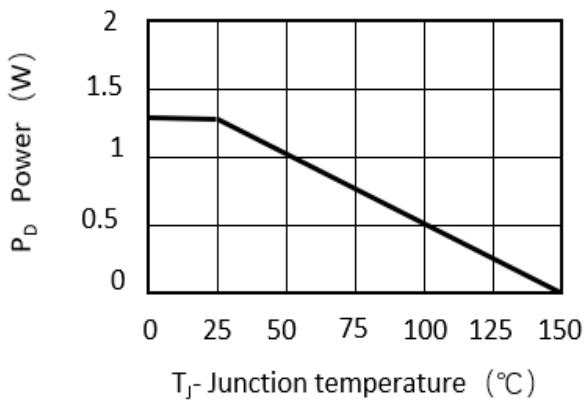


Figure 1: Power Dissipation

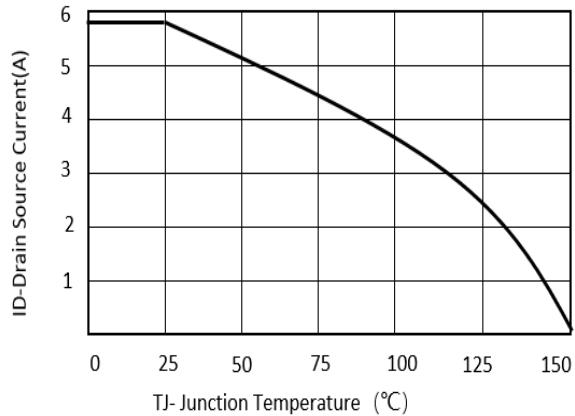


Figure 2: Drain Current

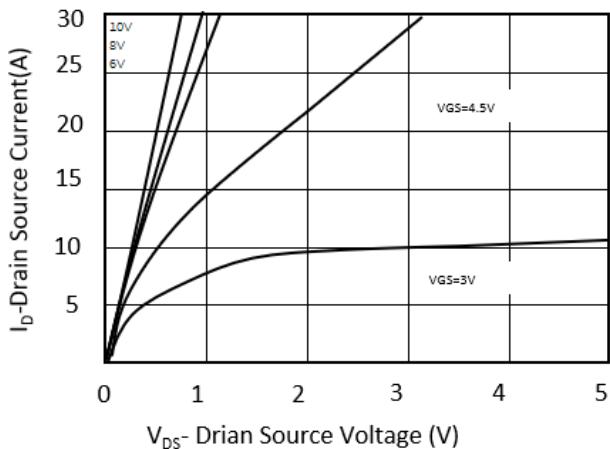


Figure 3: On-region Characteristic

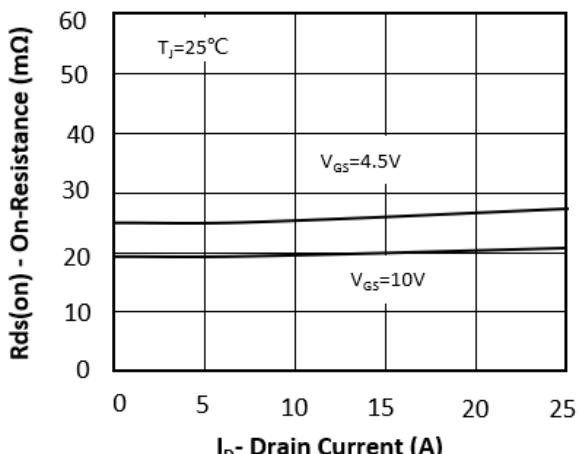


Figure 4: Drain-Source On-Resistance

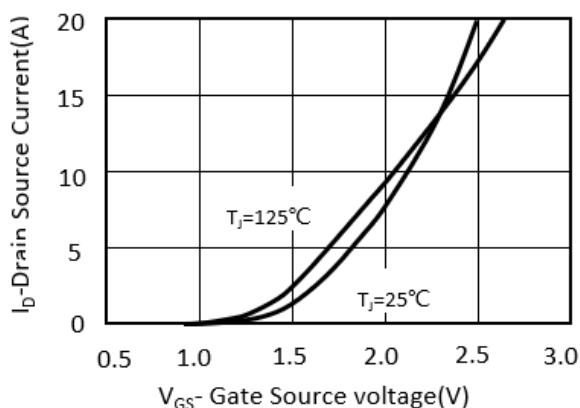


Figure 5: Transfer Characteristics

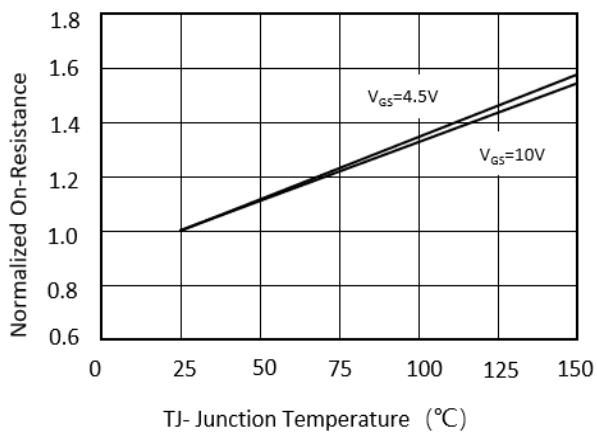


Figure 6: On-resistance VS. Junction Temperature

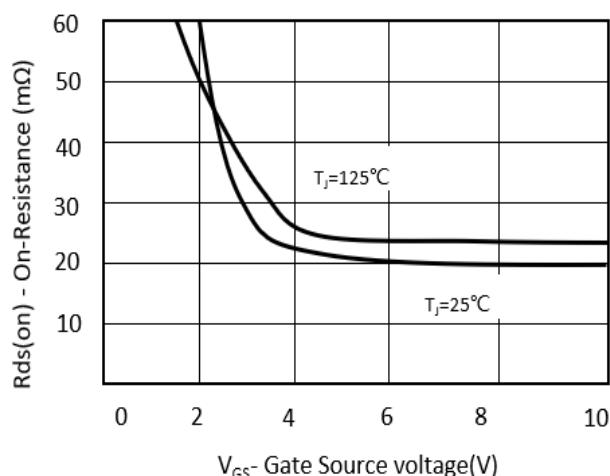


Figure 7: On-Resistance Vs. Gate Source Voltage

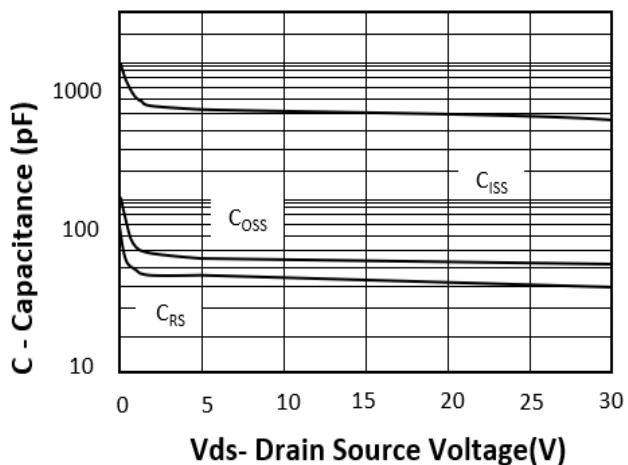


Figure 8: Capacitance Vs. Drain Source Voltage

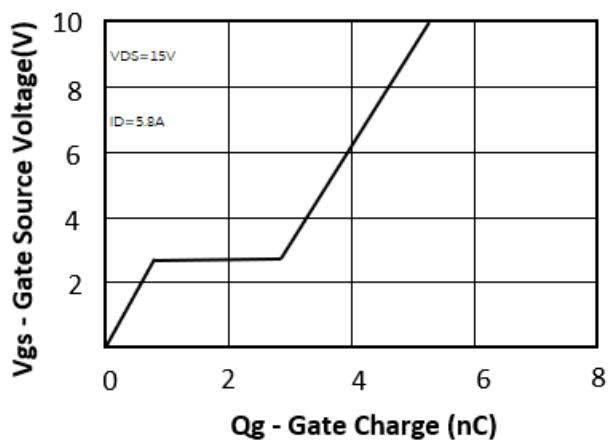


Figure 9: Gate Charge

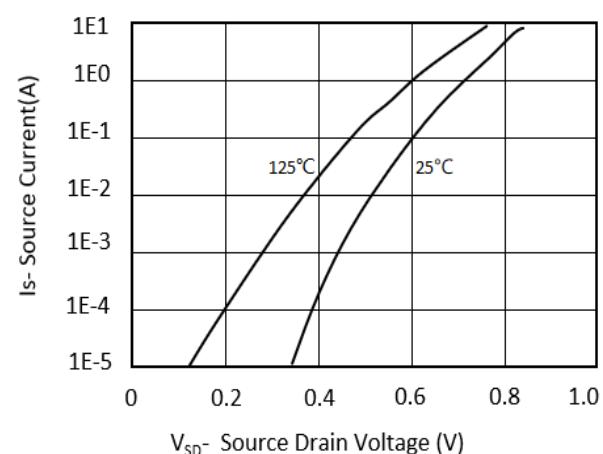


Figure 10: Source-Drain Diode Forward

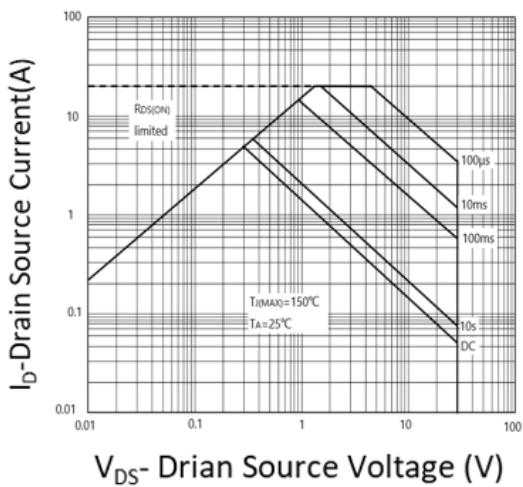


Figure 11: Safe Operation Area

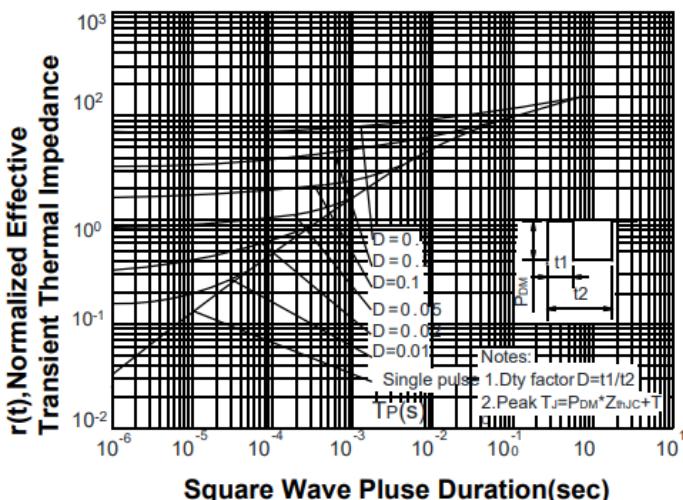
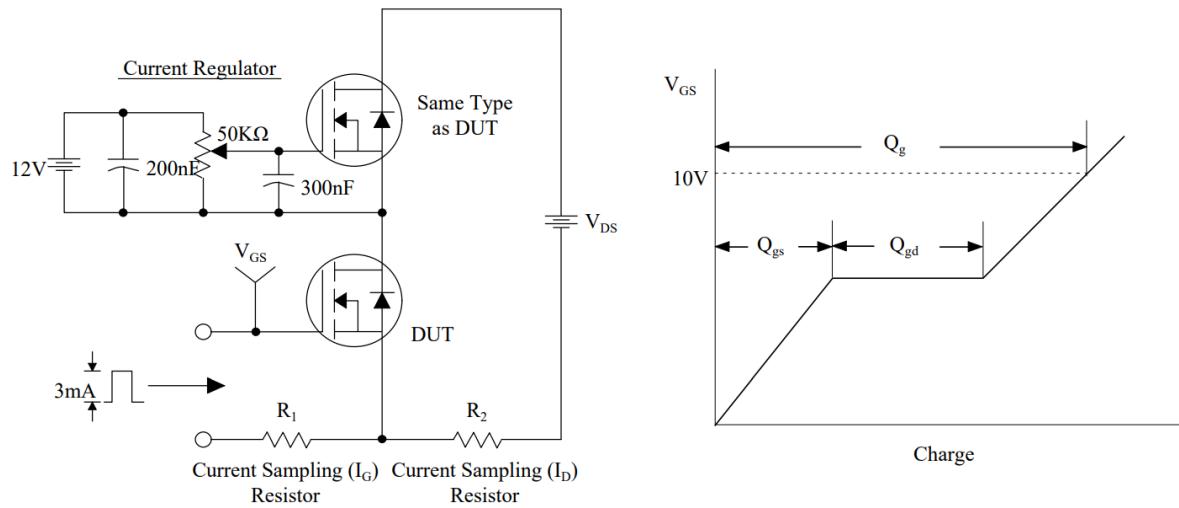
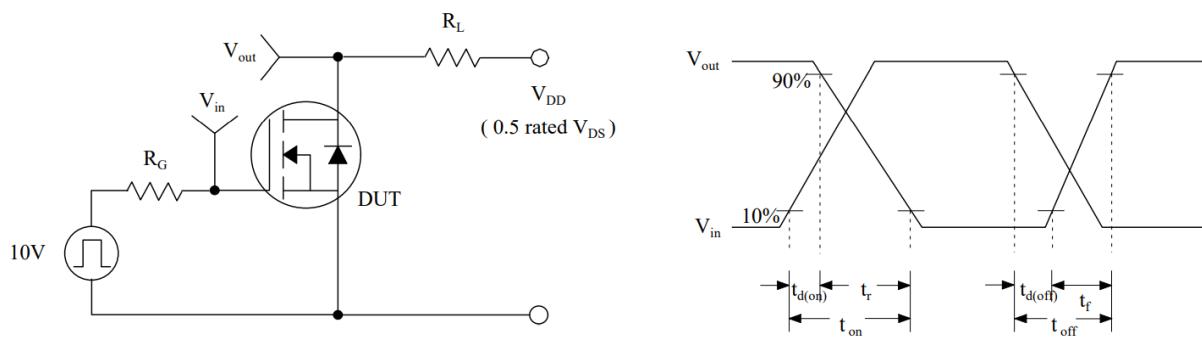


Figure 12: Transient Thermal Response Curve

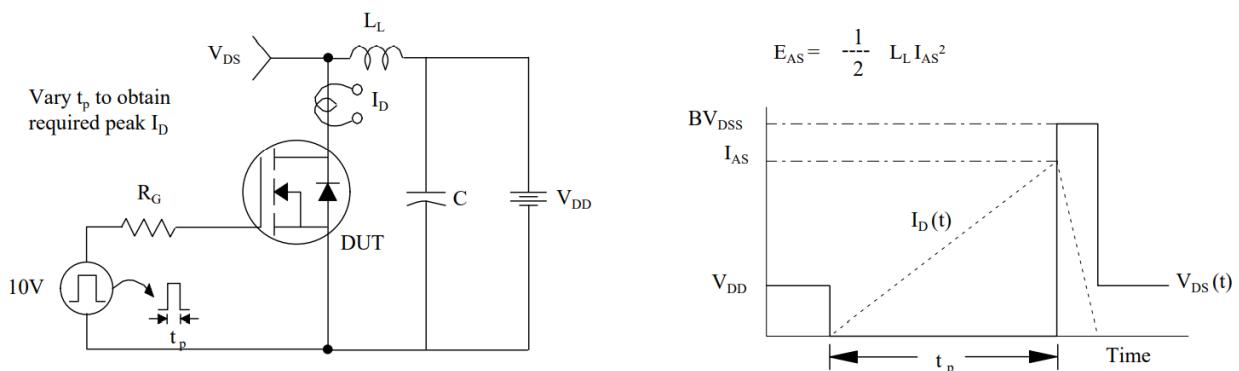
### Gate Charge Test Circuit & Waveform

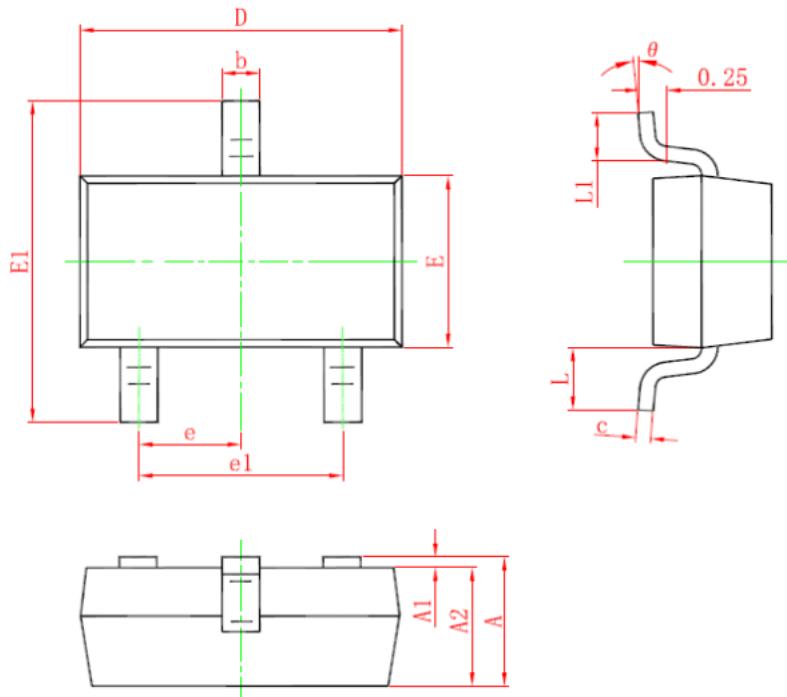


### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching Test Circuit & Waveforms



**SOT23 Package Information**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP.		0.037 TYP.	
e1	1.800	2.000	0.071	0.079
L	0.550 REF.		0.022 REF.	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

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